| Search Notes | |
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| Application/Control No. | Applicant(s)/Patent under Reexamination | _ |
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| Binh X. Tran | 1765 | |

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| SEARCH NOT (INCLUDING SEARCH | |) |
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| Search keywords and inventors' name using USPAT, USPG-PUB, JPO, EPO, DERWENT databases | 11/1/2005 | вт |
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